

Article

Gas Sensing Properties of SnO₂-Pd Nanoparticles Thick Film by Applying In Situ Synthesis-Loading Method

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Abstract: In this study, SnO₂-Pd nanoparticles(NPs) were made with an in situ synthesis-loading method. The in situ method is to simultaneously load a catalytic element during the procedure to synthesize SnO₂ NPs. SnO₂-Pd NPs were synthesized by using the in situ method and were heat-treated at 300 °C. As a result, tetragonal structured SnO₂-Pd NPs, having an ultrafine size of less than 10 nm and a uniformly distributed Pd catalyst in the SnO₂ lattice, were well made and a gas sensitive thick film with a thickness of c.a. 40 μm was well fabricated by using the NPs. Gas sensing characterization for CH₄ gas indicated that the gas sensitivity, R₃₅₀₀/R₁₀₀₀, of the thick film consistent with SnO₂-Pd NPs synthesized with the in situ synthesis-loading method, followed by heat-treatment at 500 °C, was enhanced to 0.59. Therefore, the in situ synthesis-loading method is available for synthesis of SnO₂-Pd NPs for gas sensitive thick film.

Keywords: in situ synthesis-loading; low temperature; SnO₂-Pd nanoparticles(NPs); gas sensitive thick film; gas sensitivity



Citation: Han, J.I.; Hong, S.-J. Gas Sensing Properties of SnO₂-Pd Nanoparticles Thick Film by Applying In Situ Synthesis-Loading Method. *Sensors* **2023**, *23*, 2404. <https://doi.org/10.3390/s23052404>

Academic Editor: Wooyoung Lee

Received: 29 December 2022

Revised: 1 February 2023

Accepted: 18 February 2023

Published: 21 February 2023



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1. Introduction

Semiconductor type tin oxide nanoparticles (SnO₂ NPs) have been widely used for various applications in gas sensing for a variety of gases [1–12]. Especially, SnO₂ NPs are the most reliable material to detect methane (CH₄) gas, which is a main component of natural gas, colorless, odorless, widely used in various industries and people's daily life, but may form an explosive mixture with ambient air [13]. Recently, attempts have been made to adopt this method to inorganic photo-resistance for extreme-ultraviolet (EUV) lithography [14]. The sensing mechanism is based on the adsorption reactions of gaseous species [15]. In order to cause a reaction of the ultrafine particle with the gas at lower temperature, a noble metal such as palladium (Pd) is applied as catalytic element [16,17]. The catalyst attracts the target gas and, therefore, the catalytic elements should be uniformly distributed on the surface of the SnO₂ NPs, like nano-hetero-structured materials [18,19], to enhance the sensing properties. In the current synthetic method, however, the uniformity of the catalyst distribution is not guaranteed owing to the limitation of the current method, i.e., the catalytic element is apt to be locally segregated on some part of the SnO₂ NPs because the catalyst is loaded on the surface of the solid phase NPs. In addition, chemical compounds used in the current catalyst loading method include a chloride component [20,21]. To remove the chloride, all the nano-sized particles as well as the chloride should be heated above 700 °C [22–24]. The particle coarsening occurs during the heat-treatment and, as a result, size control of the nano-dimensional particle via the current process becomes very difficult. These issues generate unstable sensitivity during long-term operation due to the growth of SnO₂ NPs at the catalyst poor region. In our research group, we studied the synthesis of SnO₂-Pd NPs by using Pd acetate instead of Pd chloride, and a low temperature catalyst adding (LTCA) method was invented [23,24].

In the literature, Pd acetate was used for adding the Pd catalyst to the surface of SnO₂ NPs. Because acetate was easily burnt out at 300 °C, SnO₂-Pd NPs were better made at a low temperature. However, uniformity of Pd distribution is still an issue in the SnO₂ NPs used as gas sensor, and the number of process steps has to decrease for cost reasons.

Thus, in this study, uniform dispersion of Pd catalysts in SnO₂ NPs was attempted. The Pd catalyst was loaded into the SnO₂ NPs during the synthesis. We named the synthetic method in situ synthesis-loading, i.e., an in situ method to load the liquid phase catalyst to the liquid phase sensing materials. Thus, synthesis-loading is performed simultaneously to advance the uniformity of catalyst distribution. As experienced in a previous study, lowering the heat-treatment temperature is important to decrease particle size [23,24]. The synthetic method proposed in this study has advantages in decreasing the synthetic process steps compared to current methods of synthesizing SnO₂-Pd NPs, and the Pd catalyst can be uniformly distributed because it is simultaneously loaded in and on the SnO₂ lattice, leading to fast response/recovery rate and long-term stability [23,24]. Considering thermal behaviors, the raw material was determined to lower the heat-treatment temperature to less than 300 °C. The SnO₂-Pd NPs synthesized with the in situ method was compared with that with the current synthetic method. Gas sensitive thick films were also fabricated to evaluate the sensing properties of the SnO₂-Pd NPs synthesized with the in situ method.

2. Materials and Methods (Figure 1)

2.1. Preparation and Evaluation of SnO₂-Pd NPs

As raw materials, Sn(II) acetate and Pd(II) acetate were used. Sn acetate was dissolved in acetone and Pd acetate was dissolved in the same solvent at a concentration of 3 wt% in SnO₂ NPs. Then, we mixed the two solutions in which Sn(II) acetate and Pd(II) acetate had been dissolved, respectively, and the mixed solution was stirred while evaporating the acetone solvent. The remaining components were then dried at 80 °C in a convection oven to erase the residual solvent, leading to a SnO₂-Pd NPs precursor. The precursor was heat-treated at 300 °C to crystallize the SnO₂-Pd NPs. For comparison, we prepared SnO₂-Pd NPs by using the current method, i.e., a Pd catalyst was loaded onto the surface of SnO₂ NPs that had already been crystallized to oxide form.

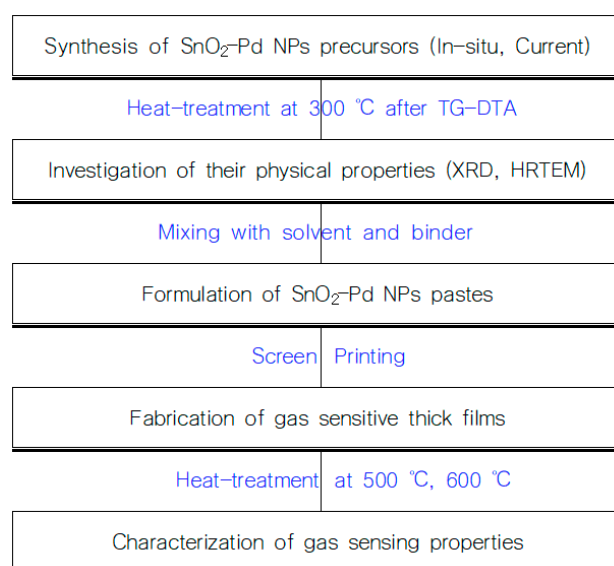


Figure 1. Example diagram of the gas sensors.

To determine whether the precursor is appropriate to the low heat-treatment temperature of 300 °C, thermal behavior was analyzed by using thermogravimetric-differential thermal analysis (TG-DTA) with temperature ranging from 25 °C to 1000 °C at a rate of 10 °C/min. Physical properties of the SnO₂-Pd NPs, after heat-treatment, were analyzed

by high resolution transmission electron microscope (HRTEM, JEOL 300 kV) with an energy dispersion Spectroscopy (EDS), X-ray diffractometer (XRD, Rigaku Rotaflex D/MAX System), Brunauer, Emmett & Teller (BET) surface area analyzer and X-ray photoelectron spectroscopy (XPS, ESCALAB 210).

2.2. Preparation and Evaluation of SnO_2 -Pd NPs Gas Sensitive Thick Films

By using the SnO_2 -Pd NPs, gas sensitive pastes were formulated with an organic based binder, along with butyl carbitol acetate (BCA) solvent. Then, by using the SnO_2 -Pd NPs pastes, gas sensitive thick films were screen-printed on the alumina substrate of size and thickness $2 \times 2 \text{ mm}^2$ and 0.25 mm, respectively. Next, to burn out the solvent and binder in the thick films, the thick film layers were heat-treated at 500 °C and 600 °C, respectively. Finally, their gas sensitivities were evaluated with 500–10,000 ppm methane (CH_4) gas while aging at 400 °C, which is the minimum operating temperature at which SnO_2 -Pd NPs react with the gas [22]. The gas sensor measurement system consists of a temperature & humidity chamber, a mass flow controller (MFC), a power supply and a computer for measuring program execution and acquisition/storage of measured data. The concentration of CH_4 gas was controlled by the gas flow rate setting value of MFC calculated for the volume of the chamber and the injection time, and the characteristics of the gas sensor were measured for the preset concentration. When the gas was injected into the chamber, a fan was operated so that the gas was evenly distributed in the chamber. The sensitivity was determined by the ratio of resistances measured at the CH_4 concentration of 3500 ppm divided by 1000 ppm, i.e., R_{3500}/R_{1000} . Since the resistance of the gas sensitive layer tends to decrease along with the increasing concentration of the CH_4 gas, the lower value of R_{3500}/R_{1000} indicates the enhanced gas sensitivity.

3. Results

3.1. Physical Properties of SnO_2 -Pd NPs

Thermal behavior of the Sn(II) acetate is shown in Figure 2a,b. Differential thermal behavior, in Figure 2a, reveals that the change in heat flow of the Sn(II) acetate was found at 270–280 °C with an exothermic reaction at 275.5 °C. In addition, a slight endothermic reaction was observed above 280 °C. The exothermic behavior is attributed to decomposition of the organic component contained in the Sn(II) acetate. In Figure 2b, the endothermic behavior after the exothermic reaction is also attributed to the oxidation of the remaining Sn element in order to form SnO_2 crystals [25]. From the thermal behavior, it is expected that SnO_2 NPs can be crystallized at below 300 °C with help of the removal of organic components at this temperature. Accordingly, the SnO_2 -Pd NPs were well synthesized with the in situ method followed by heat-treatment at 300 °C.

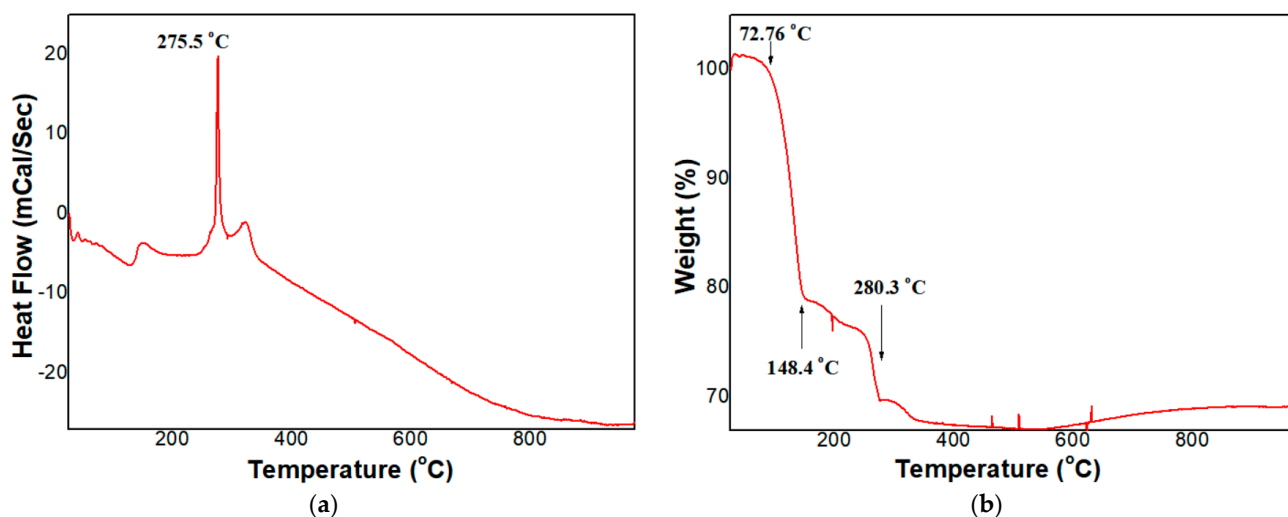


Figure 2. (a) Differential thermal analysis and (b) Thermogravimetric analysis of Sn(II) acetate.

Next, the physical properties of the SnO₂-Pd NPs synthesized with the in situ method were investigated. Firstly, their particle size was analyzed by using HRTEM. In Figure 3, the size of the synthesized particles is less than 10 nm. In addition, the Pd catalyst is loaded onto the SnO₂-Pd NPs uniformly. The cluster size of the Pd catalyst is observed to be less than 1 nm and the Pd element was certified by EDS analysis. The BET surface area analysis of the SnO₂-Pd NPs is 117 m²/g, showing very fine NPs.

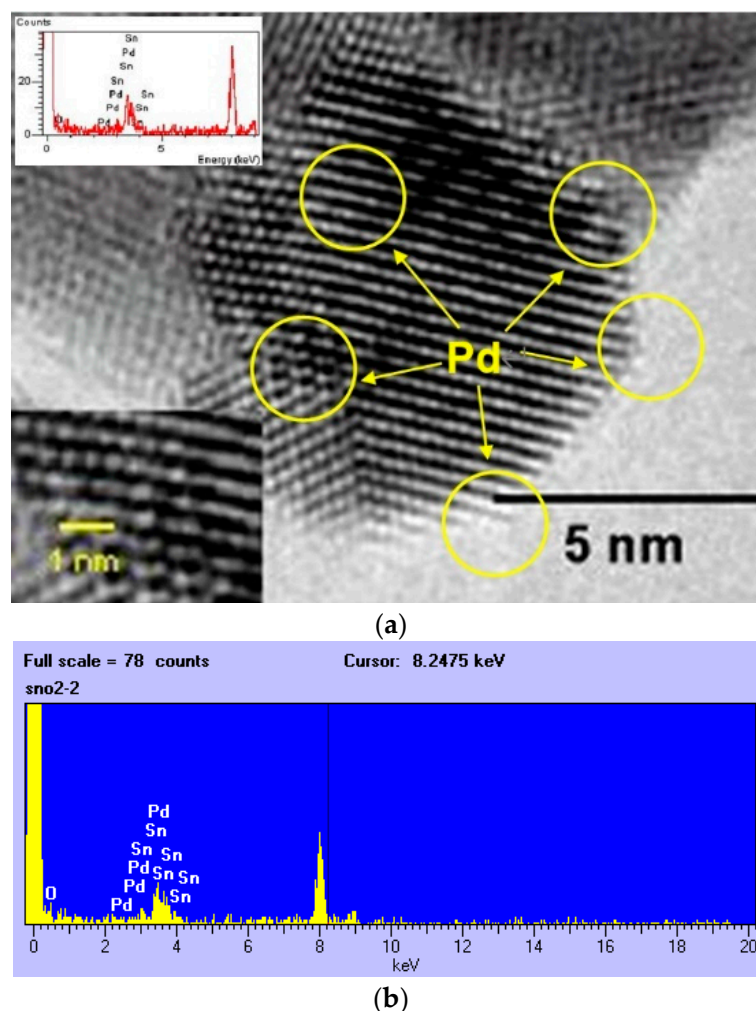


Figure 3. (a) HRTEM observation and (b) EDS analysis of SnO₂-Pd NPs synthesized with in situ method (after heat-treatment at 300 °C).

The X-ray diffraction pattern, in Figure 4a, also indicates that the Pd catalyst is uniformly distributed in the SnO₂ NPs. The diffraction pattern is in accordance with that of SnO₂ NPs synthesized with the current method as shown in Figure 4b, i.e., the NPs are consistently tetragonally structured SnO₂. Considerable peak shift is not observed in spite of Pd loading, i.e., the lattice parameter of the Pd loaded SnO₂ NPs is not changed. As a result, a diffracted peak shift is not observed, despite loading at 300 °C.

Then, we observed crystal structures of the SnO₂-Pd NPs after heat-treatment of the precursors at 300 °C, 500 °C, and 700 °C, respectively. The X-ray diffraction patterns are shown in Figure 5a–c, respectively. Tetragonal structured SnO₂ peaks are observed in all cases. Interestingly, the relative intensities of the X-ray peak diffracted at (110), (101) and (211) planes are dependent upon the temperature, i.e., the preferred orientation of the NPs is strongly associated with the temperature. Especially, (101) peak increases in proportion to the temperature. The increasing peak diffracted at (101) plane of SnO₂ overlaps with the

main X-ray peak of the PdO [26]. Therefore, it is assumed that the increase of the 101) peak is associated with the increase in the main PdO peak at 33.9° as the temperature increases.

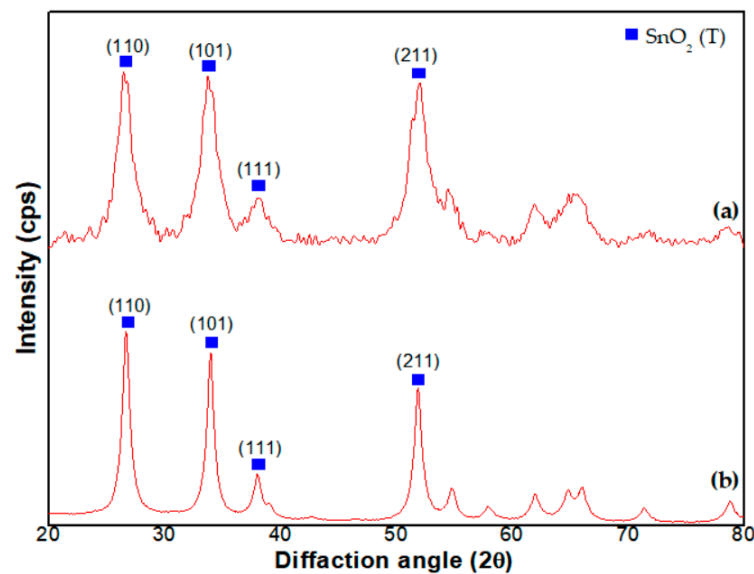


Figure 4. X-ray diffraction peaks of SnO_2 -Pd NPs synthesized with (a) in situ method and (b) current method, respectively.

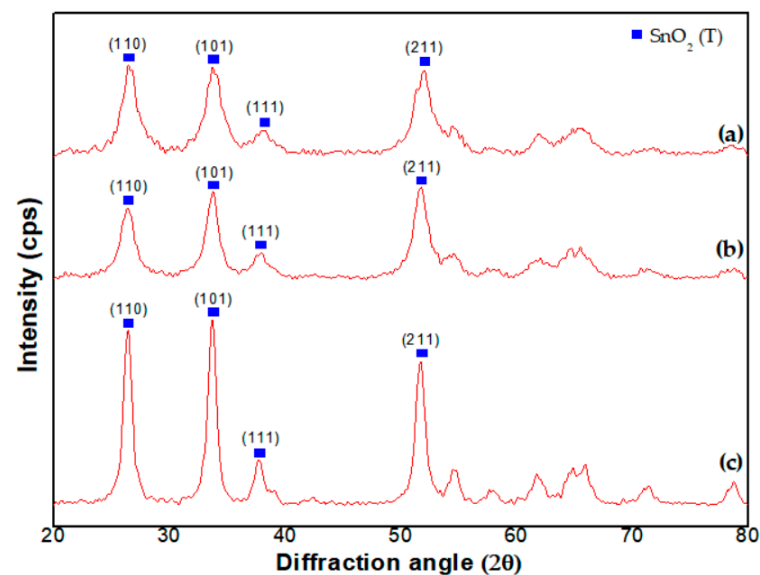


Figure 5. X-ray diffraction peaks of crystal structure of the SnO_2 -Pd NPs after heat-treatment at (a) 300 °C, (b) 500 °C and (c) 700 °C, respectively.

For quantitative analysis, we compared the crystal orientation by calculating the ratio [26], i.e., peak intensity of (110) is divided by (101) and (111), respectively. The smaller value of the orientation ratio means that the crystal structure of (110) orientation is more intensive and closer to the (110) preferred tetragonal structure. As shown in Figure 6, the ratio value of (101)/(101) and (111)/(110) is increased as the temperature increases from 300 °C to 500 °C, meaning that (101) and (111) oriented structures are more dominant than (110) oriented. From the calculation, the orientation when synthesized at 300 °C is mostly coincident with that synthesized with the current method. Therefore, the SnO_2 NPs synthesized at 300 °C are relatively well crystallized into the tetragonal structure.

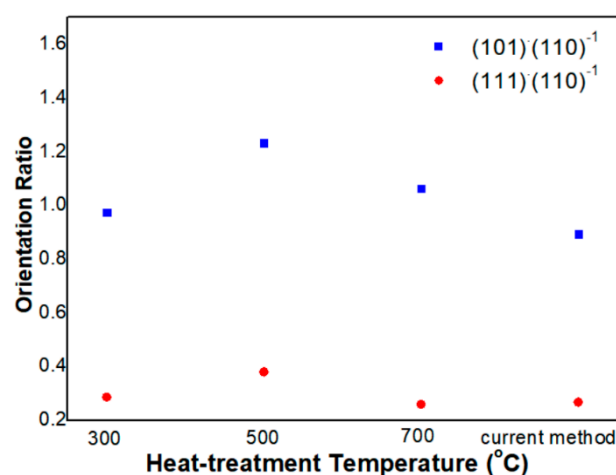


Figure 6. Crystal orientation of the SnO₂-Pd NPs synthesized under different conditions.

3.2. Gas Sensing Properties of SnO₂-Pd NPs Gas Sensitive Thick Films

Firstly, we compared the sensitivity of the SnO₂-Pd NPs synthesized with the in situ method to those synthesized with the current one. The thickness of the gas sensitive thick film is c.a. 40 μm. In Figure 7a, the resistances of the two samples are compared. The sample synthesized with the current method shows a higher resistance. Thus, a better sensitivity is expected from the sample synthesized with the current method since, conventionally, the gas sensitive thick film with the higher resistance has shown a superior sensitivity. Unexpectedly, in Figure 7b, the sample synthesized with the in situ method, having the lower resistance, showed superior sensing properties. Moreover, sensitivity of the sample synthesized with the in situ method is very stable after 5 h aging at 400 °C. On the contrary, the sensitivity of the sample synthesized with the current method is degraded according to the aging time at 400 °C.

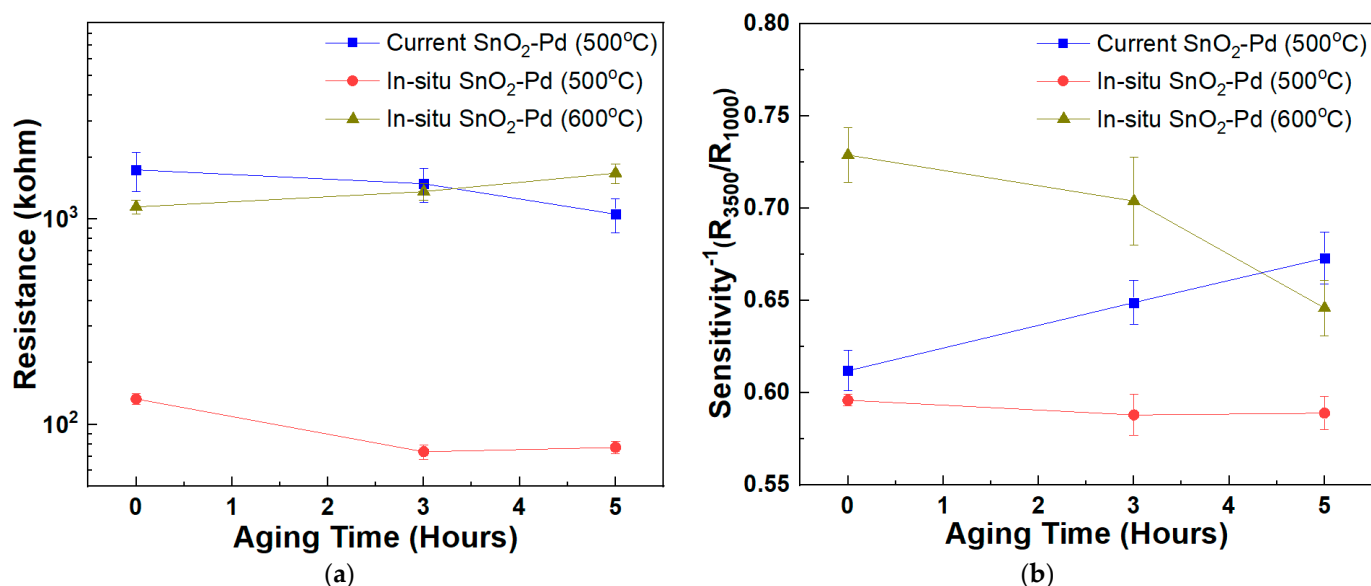


Figure 7. (a) Resistances and (b) sensitivities of gas sensitive thick films containing SnO₂-Pd NPs synthesized with current method, in situ method at 500 °C and in situ method at 600 °C, respectively.

It is assumed that this phenomenon is related to the oxygen vacancy in the SnO₂-Pd NPs. Thus, for a more detailed investigation of the oxygen vacancy, XPS analysis was carried out. As a result, in Figure 8, a difference in binding energy between the two samples was found. That is, the gas sensitive thick film containing SnO₂-Pd NPs synthesized with

the in situ method have a slightly lower binding energy than that synthesized with the current method.

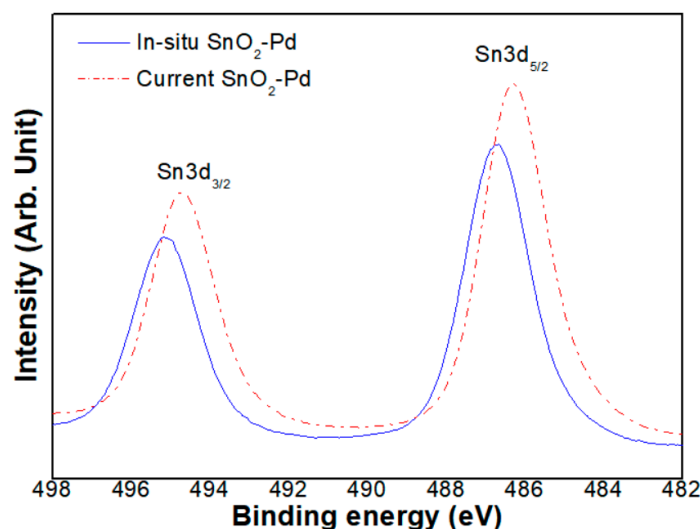


Figure 8. XPS peaks of SnO₂-Pd NPs synthesized with in situ and current methods, respectively.

To compare with the XPS result, we heat-treated the gas sensitive thick film at 600 °C. As a result, the resistance increased, accompanied by degradation of the sensitivity. This coincides with the XPS result, and the sample synthesized with the in situ method exhibits enhanced sensing properties. The R_{3500}/R_{1000} shows 0.59 and, after aging at 400 °C for 5 h, the sensitivity maintains constant value. Thus, gas sensitive thick film with good and stable sensitivity could be fabricated by applying the SnO₂-Pd NPs synthesized with the in situ method.

4. Discussion

4.1. Physical Properties of SnO₂-Pd NPs

The thermal behaviors are explained by thermal weight change of tin acetate, as shown in Figure 2b. The weight decreased steeply at temperature ranging from 72 °C to 280 °C. Most of the organic components of tin acetate are supposed to be burnt out at this temperature range. From the thermal analysis, all the organic components included in tin oxide seem to be burnt out below 300 °C. Such thermal decomposition under low temperature is enough to suppress the particle growth during the synthesis.

In addition, the X-ray diffraction pattern of SnO₂ NPs, unchanged after Pd loading, is found in previous literature [27]. This is owing to the uniform distribution of Pd in the SnO₂ lattice. In the literature, the Sn⁴⁺ ion is substituted by the loaded Pd²⁺ ion on the SnO₂ surface [27]. Because of the substitution between the two ions of similar radius, a considerable change in lattice parameter does not occur. In addition, the tendency of (101) and (111) oriented structures, more dominant than (110), is attributed to the loaded Pd catalyst [26], i.e., the PdO (101) reflection is masked with the SnO₂ (101) peak and leads to an increase of the relative intensity of this peak. The PdO originates from the oxidation of Pd at 500 °C [23]. The ratio is decreased at 700 °C, but the ratio value (101)/(110) is still higher than that synthesized at 300 °C. On the contrary, the value (111)/(110) is lower than that synthesized at this temperature.

4.2. Gas Sensing Properties of SnO₂-Pd NPs Gas Sensitive Thick Films

The difference in the sensitivity between the two samples is owing to the catalytic reaction. That is, in the case of the in situ method sample, uniform catalytic reaction is maintained despite several repetitions of the oxidation–reduction at the Pd catalyst site. However, in the case of current method sample, the reduction does not occur uniformly after oxidation of the Pd catalyst.

These behaviors, along with aging time, suppose that the active cycle of the in situ sample is attributed to oxygen vacancy near the catalyst site [28], i.e., it is probable that the oxygen vacancy acts as an electrical carrier.

The XPS peaks are attributed to a change in the Fermi level to conduction band separation [29]. It is well known that tetragonal SnO₂ is an n-type semiconductor due to the oxygen vacancies, which act as donors of the conduction electrons. An increase of the oxygen vacancies would imply a shift of Fermi level towards the conduction band, thus decreasing the binding energy. Thus, it is explained that the in situ sample shows superior sensitivity, despite lower resistance than the current sample. It is probable also that the concentration of the oxygen at the Pd catalyst site on the in situ SnO₂ NPs is lower than that on the current SnO₂ NPs. In that case, the vacant site lowers the reduction–oxidation reaction energy barrier and, as a result, the more active reaction enhances the sensitivity.

From an assumption based on XPS, the heat-treatment temperature may influence the in situ sample. That is, if the heat-treatment temperature is raised, the vacancy site on the synthesized NPs will be lowered. The resistance of the sample heat-treated at higher temperature may also increase, owing to the increase in oxygen partial pressure at the higher temperature.

5. Conclusions

In this study, SnO₂-Pd NPs were made with an in situ synthesis-loading method followed by heat-treatment at 300 °C. As a result, tetragonal structured SnO₂-Pd NPs, having an ultrafine size of less than 10 nm and a uniformly distributed Pd catalyst in the SnO₂ lattice, were well made, and the gas sensitive thick film at a thickness of c. 40 µm was well fabricated by using the NPs. Gas sensing characterization to CH₄ indicated that the gas sensitivity of the thick film consistency of SnO₂-Pd NPs synthesized with the in situ synthesis-loading method followed by heat-treatment at 500 °C was enhanced to 0.59. Therefore, the in situ synthesis-loading method is available for synthesis of SnO₂-Pd NPs for gas sensitive thick film.

Author Contributions: Writing—original draft preparation, S.-J.H.; investigation, J.I.H. and S.-J.H.; conceptualization, writing—review and editing, validation, J.I.H. and S.-J.H.; software, J.I.H. and S.-J.H.; project administration, J.I.H.; data curation, supervision, J.I.H. and S.-J.H. All authors have read and agreed to the published version of the manuscript.

Funding: This work was supported by the Technology Innovation Program (20004981, Development of Integrated Smart Seat and Skin Material Based on Electronic Fabric) funded by the Ministry of Trade, Industry and Energy (MOTIE, Republic of Korea).

Institutional Review Board Statement: Not applicable.

Informed Consent Statement: Not applicable.

Data Availability Statement: Not applicable.

Acknowledgments: This work was supported by the Technology Innovation Program (20004981, Development of Integrated Smart Seat and Skin Material Based on Electronic Fabric) funded by the Ministry of Trade, Industry and Energy (MOTIE, Republic of Korea).

Conflicts of Interest: The authors declare no conflict of interest.

References

1. Wang, W.; Zhan, Q.; Lv, R.; Wu, D.; Zhang, S. Enhancing Formaldehyde Selectivity of SnO₂ Gas Sensors with the ZSM-5 Modified Layers. *Sensors* **2021**, *21*, 3947. [\[CrossRef\]](#) [\[PubMed\]](#)
2. Ponzoni, A. Morphological Effects in SnO₂ Chemiresistors for Ethanol Detection: A Review in Terms of Central Performances and Outliers. *Sensors* **2021**, *21*, 29. [\[CrossRef\]](#) [\[PubMed\]](#)
3. Feng, Q.; Zhang, H.; Shi, Y.; Yu, X.; Lan, G. Preparation and Gas Sensing Properties of PANI/SnO₂ Hybrid Material. *Polymers* **2021**, *13*, 1360. [\[CrossRef\]](#) [\[PubMed\]](#)

4. Gulevich, D.; Rumyantseva, M.; Gerasimov, E.; Marikutsa, A.; Krivetskiy, V.; Shatalova, T.; Khmelevsky, N.; Gaskov, A. Nanocomposites SnO₂/SiO₂ for CO Gas Sensors: Microstructure and Reactivity in the Interaction with the Gas Phase. *Materials* **2019**, *12*, 1096. [[CrossRef](#)] [[PubMed](#)]
5. Izawa, K. SnO₂-Based Gas Sensor for Detection of Refrigerant Gases. *Proceedings* **2019**, *14*, 32.
6. Nazemi, H.; Joseph, A.; Park, J.; Emadi, A. Advanced Micro- and Nano-Gas Sensor Technology: A Review. *Sensors* **2019**, *19*, 1285. [[CrossRef](#)]
7. Suematsu, K.; Ma, N.; Watanabe, K.; Yuasa, M.; Kida, T.; Shimanoe, K. Effect of Humid Aging on the Oxygen Adsorption in SnO₂ Gas Sensors. *Sensors* **2018**, *18*, 254. [[CrossRef](#)]
8. Xue, N.; Zhang, Q.; Zhang, S.; Zong, P.; Yang, F. Highly Sensitive and Selective Hydrogen Gas Sensor Using the Mesoporous SnO₂ Modified Layers. *Sensors* **2017**, *17*, 2351. [[CrossRef](#)]
9. Tan, W.; Ruan, X.; Yu, Q.; Yu, Z.; Huang, X. Fabrication of a SnO₂-Based Acetone Gas Sensor Enhanced by Molecular Imprinting. *Sensors* **2015**, *15*, 352–364. [[CrossRef](#)]
10. Batzill, M. Surface Science Studies of Gas Sensing Materials: SnO₂. *Sensors* **2006**, *6*, 1345–1366. [[CrossRef](#)]
11. Sun, Y.; Huang, X.; Meng, F.; Liu, J. Study of Influencing Factors of Dynamic Measurements Based on SnO₂ Gas Sensor. *Sensors* **2004**, *4*, 95–104. [[CrossRef](#)]
12. Morrison, S.R. Selectivity in Semiconductor Gas Sensors. *Sens. Actuators* **1987**, *12*, 425–440. [[CrossRef](#)]
13. Nasresfahani, S.; Sheikhi, M.H.; Tohidi, M.; Zarifkar, A. Methane Gas Sensing Properties of Pd-Doped SnO₂/Reduced Graphene Oxide Synthesized by a Facile Hydrothermal Route. *Mater. Res. Bull.* **2017**, *89*, 161–169. [[CrossRef](#)]
14. Luo, C.; Xu, C.; Lv, L.; Li, H.; Huang, X.; Liu, W. Review of Recent Advances in Inorganic Photoresists. *RSC Adv.* **2020**, *10*, 8385–8395. [[CrossRef](#)]
15. Blaser, G.; Ruhl, T.; Diehl, C.; Ulrich, M.; Kohl, D. Nanostructured Semiconductor Gas Sensors to Overcome Sensitivity Limitations Due to Percolation Effects. *Phys. A* **1999**, *266*, 218–223. [[CrossRef](#)]
16. Schweizer-Berberich, M.; Zheng, J.G.; Weimar, U.; Gopel, W.; Barsan, N.; Pentia, E.; Tomescu, A. The Effect of Pt and Pd Surface Doping on the Response of Nanocrystalline Tin Dioxide Gas Sensors to CO. *Sens. Actuators B Chem.* **1996**, *31*, 71–75. [[CrossRef](#)]
17. Dieguez, A.; Vila, A.; Cabot, A.; Romano-Rodriguez, A.; Morante, J.R.; Kappler, J.; Barsan, N.; Weimar, U.; Gopel, W. Influence on the Gas Sensor Performances of the Metal Chemical States Introduced by Impregnation of Calcinated SnO₂ Sol-Gel Nanocrystals. *Sens. Actuators B Chem.* **2000**, *68*, 94–99. [[CrossRef](#)]
18. Santos, R.B.D.; Rivelino, R.; Mota, F.D.B.; Kakanakova-Georgieva, A.; Gueorguiev, G.K. Feasibility of novel (H₃C)_nX(SiH₃)₃–n compounds (X = B, Al, Ga, In): Structure, stability, reactivity, and Raman characterization from ab initio calculations. *Dalton Trans.* **2015**, *44*, 3356–3366. [[CrossRef](#)]
19. Bakoglidis, K.D.; Palisaitis, J.; Santos, R.B.D.; Rivelino, R.; Persson, P.O.Å.; Gueorguiev, G.K.; Hultman, L. Self-Healing in Carbon Nitride Evidenced as Material Inflation and Superlubric Behavior. *ACS Appl. Mater. Interfaces* **2018**, *10*, 16238–162430. [[CrossRef](#)]
20. Cirera, A.; Romano-Rodriguez, A.; Morante, J.R.; Weimar, U.; Schweizer-Berberich, M.; Gopel, W. Morphological Analysis of Nanocrystalline SnO₂ for Gas Sensor Applications. *Sens. Actuators B Chem.* **1996**, *31*, 1–8.
21. Cirera, A.; Diéguez, A.; Diaz, R.; Cornet, A.; Morante, J.R. New Method to Obtain Stable Small-Sized SnO₂ Powders for Gas Sensors. *Sens. Actuators B Chem.* **1999**, *58*, 360–364. [[CrossRef](#)]
22. Ibarguen, C.A.; Mosquera, A.; Parra, R.; Castro, M.S.; Rodríguez-Páez, J.E. Synthesis of SnO₂ Nanoparticles through the Controlled Precipitation Route. *Mater. Chem. Phys.* **2007**, *101*, 433–440. [[CrossRef](#)]
23. Hong, S.-J.; Han, J.-I. Effect of Low Temperature Composite Catalyst Loading (LTC²L) on Sensing Properties of Nano Gas Sensor. *Sens. Actuators A Phys.* **2004**, *112*, 80–86. [[CrossRef](#)]
24. Hong, S.-J.; Han, J.-I. Low-Temperature Catalyst Adding for Tin–Oxide Nanostructure Gas Sensors. *IEEE Sens. J.* **2005**, *5*, 12–19. [[CrossRef](#)]
25. Fenerty, J.; Humphries, P.G.; Pearce, J. The Reconstructive Decomposition of Tin(II) Formate in Oxidising and Inert Atmospheres. *Thermochim. Acta* **1983**, *61*, 319–327. [[CrossRef](#)]
26. Pramanik, N.C.; Das, S.; Biswas, P.K. The Effect of Sn (IV) on Transformation of Co-Precipitated Hydrated In (III) and Sn (IV) Hydroxides to Indium Tin Oxide (ITO) Powder. *Mater. Lett.* **2002**, *56*, 671–679. [[CrossRef](#)]
27. De, G.; Licciulli, A.; Massaro, C.; Quirini, A.; Rella, R.; Siciliano, P.; Vasanelli, L. Sol-Gel Derived Pure and Palladium Activated Tin Oxide Films for Gas-Sensing Applications. *Sens. Actuators B Chem.* **1999**, *55*, 134–139. [[CrossRef](#)]
28. Maruyama, T.; Morishita, T. Tin Dioxide Thin Films Prepared by Photochemical Vapour Deposition from Tin (II) Acetate. *Thin Solid Films* **1994**, *251*, 19–22. [[CrossRef](#)]
29. Cirera, A.; Cornet, A.; Morante, J.R.; Olaizola, S.M.; Castano, E.; Gracia, J. Comparative structural study between sputtered and liquid pyrolysis nanocrystalline SnO₂. *Mater. Sci. Eng. B* **2000**, *69–70*, 406–410. [[CrossRef](#)]

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